MX PARALLEL LASER MICROMETER

Features

Compact size No Separate External Controllers Measurement Range: 0 to 28mm Sub-micron Resolution of 0.4375 µm Non-Linearity <5µm Repeatability <3µm Very Fast 2500 measurements/s Parallel TTL interface Laser diode 670nm Class I

Applications

Measurement of various types of materials in a wide range of industries (metal ,plastic, glass, ceramics, wood and others)

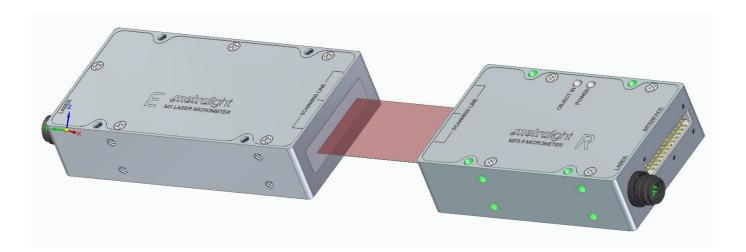
Measurement of Edge, Gap, Diameter, Position, Thickness, Height, Profile, and Vibration of objects.

Diameter measurement of tube and pipe (in process or sampling)

Precise and fast online/offline noncontact measurement of objects.

Semiconductor atmospheric/vacuum prealigner

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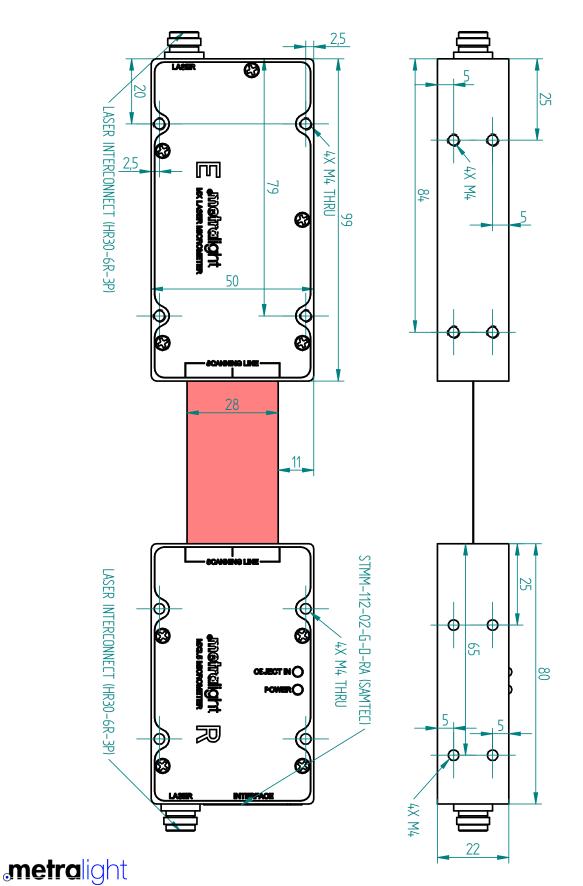


Options

Custom Modes: Centering, MIN/MAX measurement, Thickness, Range of Tolerances, Runout, object filtering, eccentricity
Integrated OLED display
Custom Sensor Size and Package available
Custom Applications

2. DIMENSIONS

MX PAR MICROMETER



email at: info@metralight.com For detailed dimensions, please download 2D drawing or 3D model from http://www.metralight.com or

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3. SPECIFICATION

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Measurement

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Sensor Range	140µm (0.006 in) up to 28 mm (1.1 in)
Resolution (Pixel size)	0.4375 μm
Repeatability	3 μm (Edge position, calibrated distance) *
Response Time	0.391 ms
Non-Linearity	<5 μm (Edge position, calibrated distance) *
Measuring Modes	Edge1, Edge2, Diameter, Gap, Center, Solid
Custom Modes	Call Metralight for additional custom modes

Interface

Indicators	Green LED = Sensor ON ; Blue LED = Object Present
I/O connectors	STMM-112-02-G-D-RA (Samtec)
Interface (I/O)	Parallel binary (TTL)
Power supply	12 to 24 VDC / 80mA

General

Detection Method	670nm Class I Laser Diode through-beam with CCD	
Overall Dimension	99 x 50 x 22 mm (3.9" x 1.9" x 0.9") 80 x 50 x 22 mm (3.15" x 1.9" x 0.9")	
Mounting holes	M4 (8 positions) each box	
Weight	236g (8oz)	
Operating Temp.	0°C to 50°C (32°F to 122°F)	
Storage Temp.	-20°C to 70°C (-4°F to 158°F)	

*) If mounted on Rail.



4. SPECIFICATION

| MX PAR MICROMETER

MX Parallel Laser Micrometer uses a parallel beam to measure position or size of objects. An object is simply placed in the detection line, and the measured edge (in case of diameter - both edges) must be in the active area.

The position and size of the shadow is measured via the CMOS line image sensor. Gap and Center can also be measured (see picture bellow).

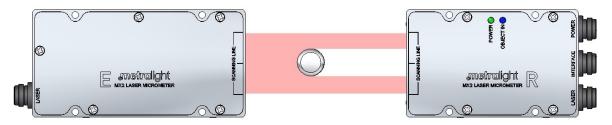
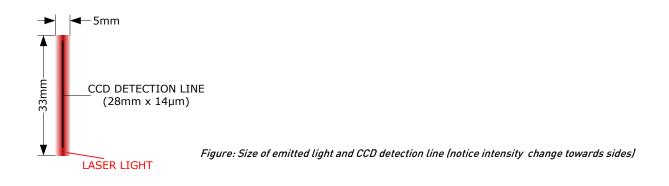


Figure: Parallel beam and shadow of an object

The Receiver and the Emitter part must be aligned properly. Since the emitted light is wider than the CMOS detector line, alignment is simple and easy.

If the requirements of the application are for the highest accuracy, it is recommended that the unit be mounted on a rail from the factory.



Sensor processes CMOS data and outputs measurement in a binary pixel format representing position/size of object(s). Sensor processing can also be customized upon customer request, to include maximum/minimum, average values, etc.



3. INTERFACE

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| MX PAR MICROMETER

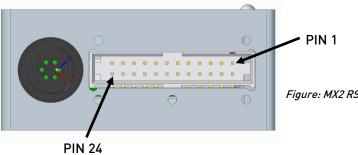


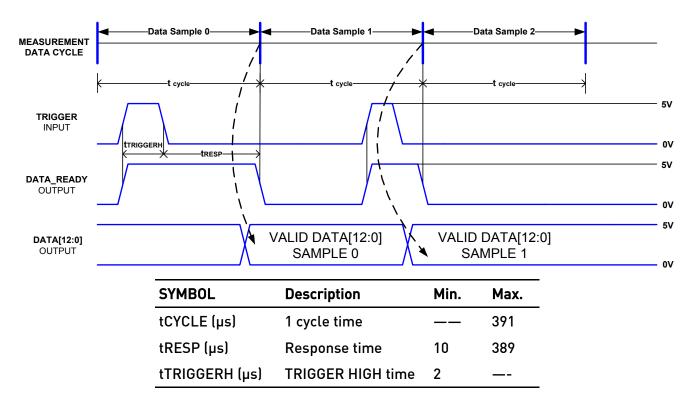
Figure: MX2 RS232, Analog interface

MX Parallel 3.5µm resolution			MX F	MX Parallel 0.43	
PIN #	PIN TYPE	Description		PIN #	PIN # PIN TYPE
1	OUT	Data bit 0 (LSB)		1	1 OUT
2	OUT	Data bit 1	2		OUT
3	OUT	Data bit 2	3		OUT
4	OUT	Data bit 3	4		OUT
5	OUT	Data bit 4	5		OUT
6	OUT	Data bit 5	6		OUT
7	OUT	Data bit 6	7		OUT
8	OUT	Data bit 7	8		OUT
9	OUT	Data bit 8	9		OUT
10	OUT	Data bit 9	10		OUT
11	OUT	Data bit 10	11		OUT
12	OUT	Data bit 11	12		OUT
13	OUT	Data bit 12 (MSB)	13		OUT
14	OUT	DATA READY	14	(TUC
15	IN	TRIGGER	15	ľ	N
16	OUT	OBJECT IN	16	0	UT
17	IN	MODEO	17	01	UT
18	IN	MODE1	18	01	JT
19	IN	MODE2	19	01	UT
20	IN	MODE3	20	11	١
21,22	PWR	+12 to 24VDC	21,22	Ρ	WR
23,24	GND	GND	23,24	GI	ND

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DATA READING

| MX PAR MICROMETER



MX Parallel 3.5µm resolution, measuring modes				g modes
MODE3	MODE2	MODE1	MODE0	Mode description
0	0	0	0	Edge 1
0	0	0	1	Edge 2
0	0	1	0	Diameter
0	0	1	1	Gap
0	1	0	0	Center
0	1	0	1	Solid Edge

MX Parallel 0.4375µm resolution, measuring modes		
Mode description		
Edge 1		
Diameter		





MX PAR MICROMETER

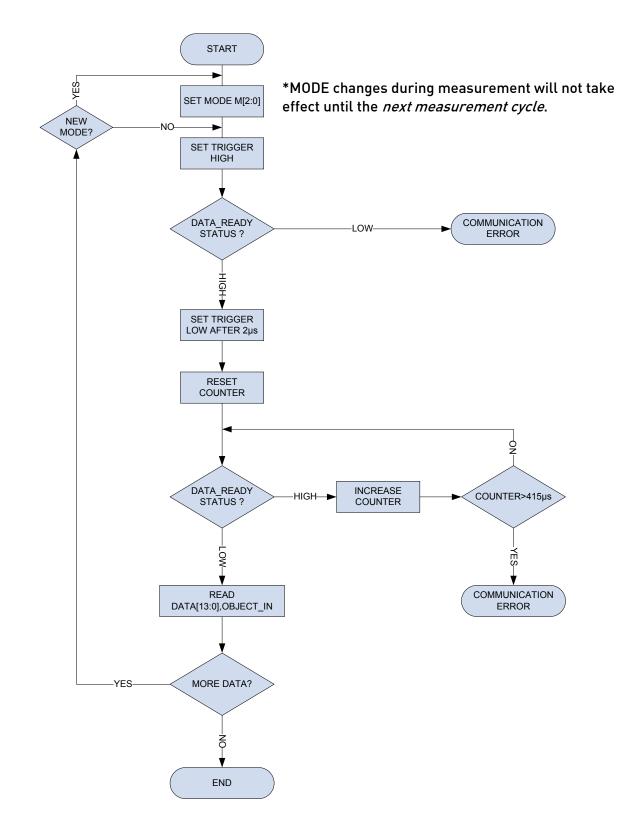
HIGH to LOW transition on the TRIGGER, commences a data output at the end of the current measurement cycle. The HIGH to LOW signal on the DATA_READY confirms a Valid Data event. The maximum response time between the TRIGGER input and the DATA_READY output is 391µs. This DATA is presented to the output pins and retained until the next TRIGGER event. In the absence of a TRIGGER event, the previous data will be held indefinitely. This process allows slow processing computers to bypass several measurement cycles between measurement readings. MODE changes during measurement will not take effect until the *next measurement cycle*. *See Flowchart on next page for typical operation.*

Default measuring mode is DIAMETER. For mode change it's necessary to make a transition on MODE[] pins.



TYPICAL FLOWCHART

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5. SAMPLE APPLICATION

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Metralight provides sample application (MX_Terminal, see below), this is a demonstration application which reads and display/save data (and export to Excel). Source code is included for custom modification. Please contact Metralight for any SW modification/development. Metralight provides a complete solution HW+SW and mechanical.



Figure: MicroStudio SW



5. INSTALLATION

| MX PAR MICROMETER

- USE APPROPRIATE MOUNTING SCREWS (SEE MECHANICAL DRAWING)
- AVOID DIRECT SUNLIGHT !!! AND ALL OTHER LIGHT SOURCES WITH WAVELENGTH CLOSE TO 670nm (see Optical filter transmittance on figure below).
- ALWAYS KEEP OPTICAL WINDOWS CLEAN, FREE FROM DUST AND FINGERPRINTS, AVOID SCRATCHES ON THE OPTICAL WINDOWS.
- APPLY CORRECT VOLTAGE SEE ELECTRICAL SPECIFICATION

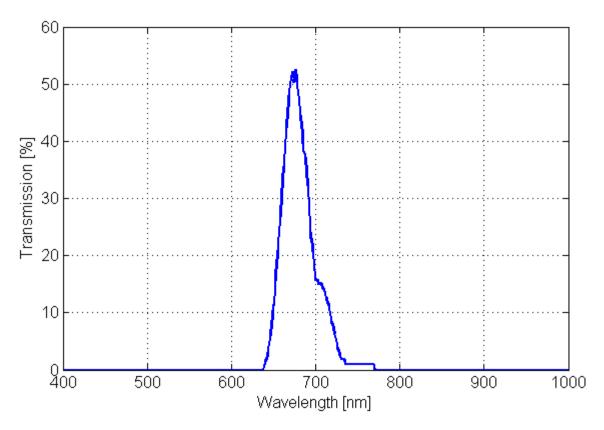


Figure: Ambient light optical filter

5. PACKAGE, WARRANTY

| MX PAR MICROMETER

Package components

- · Sensor units: 1x Laser light source and 1x Receiver
- Interconnect cable
- · Parallel output cable (Flat ribbon)

Warranty

METRALIGHT provides a **ONE YEAR** manufacturer's limited warranty against defective materials and workmanship. Please do not attempt to open the unit, as this will void all warranties.

Contacts

METRALIGHT, Inc. 533 Airport Blvd., Suite #400 Burlingame, CA 94010 phone: (650) 581 3088, fax: (650) 808 9830 email: sales@metralight.com technical support: support@metralight.com web site: http://www.metralight.com



5. APPENDIX A: MODES.. I MX PAR MICROMETER

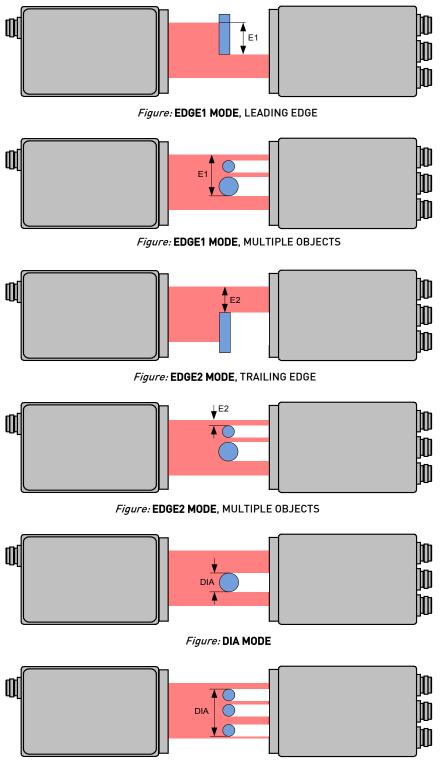


Figure: DIA MODE, MULTIPLE OBJECTS

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5. APPENDIX A: ..MODES

| MX PAR MICROMETER

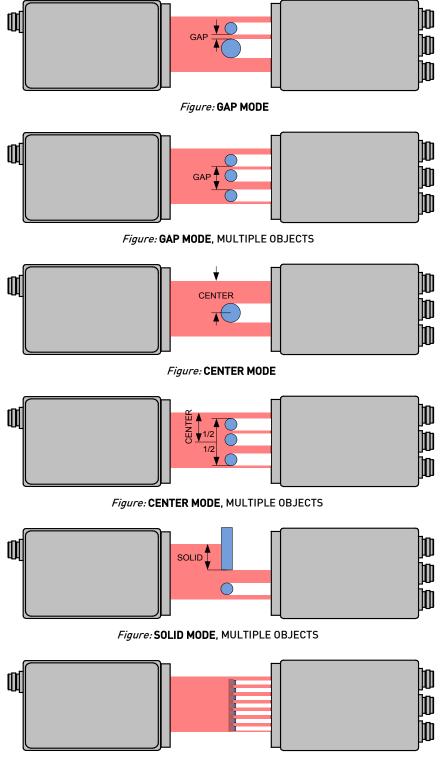


Figure: **CUSTOM MODE**, For Example IC LEADS Dimension measurement OR Detects BENT Leads or Missing Leads.

